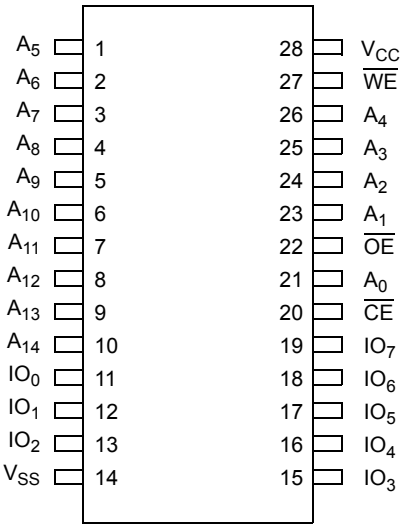
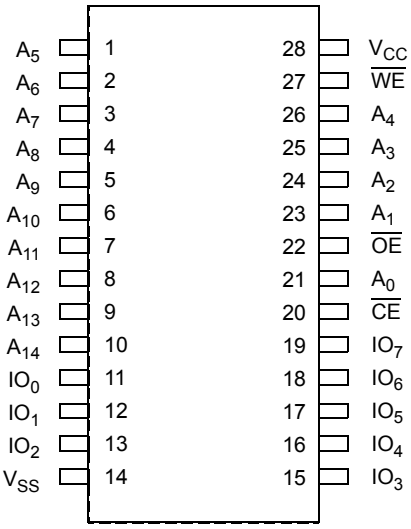
Contents

Pin Layout and Specifications

28-pin DIP



28-pin SOJ



Pin Description

Pin	Type	Description	DIP	SOJ
A_X	Input	Address inputs	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 21, 23, 24, 25, 26	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 21, 23, 24, 25, 26
$\overline{CE}$	Control	Chip Enable	20	20
IO_X	Input or Output	Data input outputs	11, 12, 13, 15, 16, 17, 18, 19	11, 12, 13, 15, 16, 17, 18, 19
$\overline{OE}$	Control	Output enable	22	22
V_{CC}	Supply	Power (5.0 V)	28	28
V_{SS}	Supply	Ground	14	14
$\overline{WE}$	Control	Write Enable	27	27

Note
1. For best practices recommendations, refer to the Cypress application note *System Design Guidelines* on www.cypress.com.

Truth Table

$\overline{CE}$	$\overline{OE}$	$\overline{WE}$	IOx	Mode	Power
H	X	X	High-Z	Deselect/Power-down	Stand by (I_{SB})
L	L	H	Data Out	Read	Active (I_{CC})
L	X	L	Data In	Write	Active (I_{CC})
L	H	H	High-Z	Selected, Outputs disabled	Active (I_{CC})

Maximum Ratings

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Parameter [2]	Description	Value	Unit
T_{STG}	Storage temperature	–65 to +150	°C
T_{AMB}	Ambient temperature with power applied (that is, case temperature)	–55 to +125	°C
V_{CC}	Core Supply voltage relative to V_{SS}	–0.5 to +7.0	V
V_{IN}, V_{OUT}	DC voltage applied to any pin relative to V_{SS}	–0.5 to V_{CC} + 0.5	V
I_{OUT}	Output short-circuit current	20	mA
V_{ESD}	Static discharge voltage (in accordance with MIL-STD-883, Method 3015)	> 2001	V
I_{LU}	Latch-up current	> 200	mA

Operating Range

Range	Ambient Temperature (T_A)	Voltage Range (V_{CC})
Commercial	0 °C to 70 °C	5.0 V ± 10%
Industrial	–40 °C to 85 °C	5.0 V ± 10%

DC Electrical Characteristics

Over the Operating Range

Parameter [2]	Description	Condition		-15		Unit
				Min	Max	
V_{IH}	Input HIGH voltage			2.2	V_{CC} + 0.3	V
V_{IL}	Input LOW voltage			–0.5	0.8	V
V_{OH}	Output HIGH voltage	V_{CC} = Min, I_{OH} = –4.0 mA		2.4	–	V
V_{OL}	Output LOW voltage	V_{CC} = Min, I_{OL} = 8.0 mA		–	0.4	V
I_{CC}	V_{CC} Operating supply current	V_{CC} = Max, I_{OUT} = 0 mA, f = F_{max} = $1/t_{RC}$		–	80	mA
I_{SB1}	Automatic $\overline{CE}$ power-down current – TTL inputs	Max V_{CC}, $\overline{CE} \geq V_{IH}$, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$, f = F_{max}		–	30	mA
			L	–	10	mA
I_{SB2}	Automatic $\overline{CE}$ power-down current – CMOS Inputs	Max V_{CC}, $\overline{CE} \geq V_{CC}$ – 0.3 V, $V_{IN} \geq V_{CC}$ – 0.3 V, or $V_{IN} \leq$ 0.3 V, f = 0		–	10	mA
			L	–	500	µA
I_{OZ}	Output leakage current	GND ≤ V_I ≤ V_{CC}, output disabled		–5	+5	µA
I_{IX}	Input leakage current	GND ≤ V_I ≤ V_{CC}		–5	+5	µA

Note
2. V_{IL} (min) = –2.0 V for pulse durations of less than 20 ns.

Capacitance

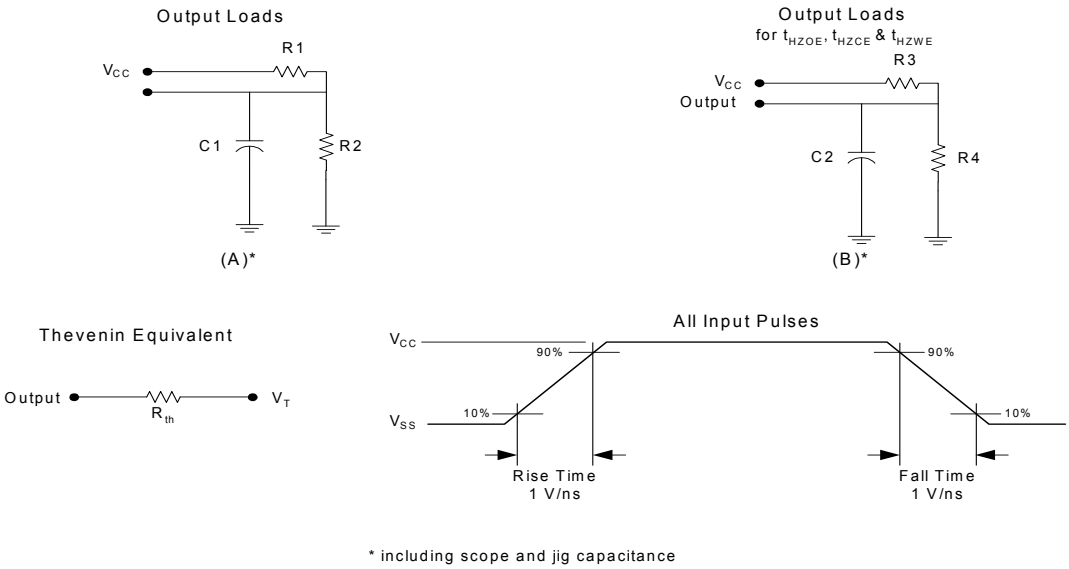
Parameter [3]	Description	Conditions	Max	Unit
C_{IN}	Input capacitance	T_A = 25 °C, f = 1 MHz, V_{CC} = 5.0 V	8	pF
C_{OUT}	Output capacitance		8	

Thermal Resistance

Parameter [3]	Description	Conditions	SOJ	DIP	Unit
θ_{JA}	Thermal resistance (junction to ambient)	Still air, soldered on a 3 × 4.5 square inch, two–layer printed circuit board	79	69.33	°C/W
θ_{JC}	Thermal resistance (junction to case)		41.42	31.62	

AC Test Loads

Figure 1. AC Test Loads



* including scope and jig capacitance

AC Test Conditions

Parameter	Description	Nom	Unit
C1	Capacitor 1	30	pF
C2	Capacitor 2	5	
R1	Resistor 1	480	Ω
R2	Resistor 2	255	
R3	Resistor 3	480	
R4	Resistor 4	255	
R_{TH}	Resistor Thevenin	167	
V_{TH}	Voltage Thevenin	1.73	V

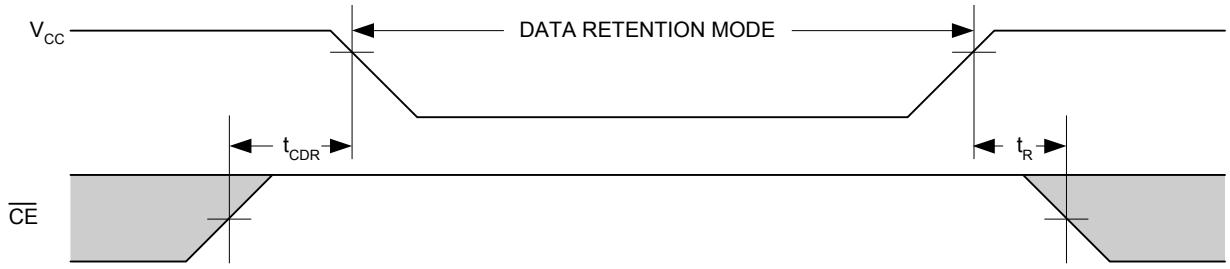
Note
3. Tested initially and after any design or process change that may affect these parameters.

Data Retention Characteristics

Parameter [4]	Description	Condition	Min	Max	Unit
V_{DR}	V_{CC} for data retention		2.0	–	V
I_{CCDR}	Data retention current	$V_{CC} = V_{DR} = 2.0$ V, $\overline{CE} \geq V_{CC} - 0.3$ V, $V_{IN} \geq V_{CC} - 0.3$ V or $V_{IN} \leq 0.3$ V	–	150	µA
t_{CDR}	Chip deselect to data retention time		0	–	ns
t_R	Operation recovery time		200	–	µs

Data Retention Waveform

Figure 2. Data Retention Waveform



Note
4. L-version only.

AC Electrical Characteristics

Parameter [5, 6]	Description	–15		Unit
		Min	Max	
t_{RC}	Read cycle time	15	–	ns
t_{AA}	Address to data valid	–	15	ns
t_{OHA}	Data hold from address change	3	–	ns
t_{ACE}	$\overline{CE}$ to data valid	–	15	ns
t_{DOE}	$\overline{OE}$ to data valid	–	7	ns
t_{LZOE}	$\overline{OE}$ to Low-Z [7]	0	–	ns
t_{HZOE}	$\overline{OE}$ to High-Z [7, 8]	–	7	ns
t_{LZCE}	$\overline{CE}$ to Low-Z [7]	3	–	ns
t_{HZCE}	$\overline{CE}$ to High-Z [7, 8]	–	7	ns
t_{PU}	$\overline{CE}$ to Power-up	0	–	ns
t_{PD}	$\overline{CE}$ to Power-down	–	15	ns
t_{WC}	Write Cycle Time [9]	15	–	ns
t_{SCE}	$\overline{CE}$ to write end	10	–	ns
t_{AW}	Address setup to write end	10	–	ns
t_{HA}	Address hold from write end	0	–	ns
t_{SA}	Address setup to write start	0	–	ns
t_{PWE}	$\overline{WE}$ pulse width	9	–	ns
t_{SD}	Data setup to write end	9	–	ns
t_{HD}	Data hold from write end	0	–	ns
t_{HZWE}	$\overline{WE}$ LOW to High-Z [7, 8]	–	7	ns
t_{LZWE}	$\overline{WE}$ HIGH to Low-Z [7]	3	–	ns

Notes

5. Test Conditions are based on a transition time of 3 ns or less and timing reference levels of 1.5 V, and input pulse levels of 0 to 3.0 V.
6. The minimum write cycle pulse width for Write Cycle No. 3 ($\overline{WE}$ Controlled, $\overline{OE}$ LOW) should be equal to sum of t_{SD} and t_{HZWE}.
7. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE}, t_{HZOE} is less than t_{LZOE}, and t_{HZWE} is less than t_{LZWE} for any given device.
8. t_{HZOE}, t_{HZCE}, t_{HZWE} are specified as in part (b) of the Figure 1 on page 6. Transitions are measured ± 200 mV from steady state voltage.
9. The internal memory write time is defined by the overlap of $\overline{CE}$ LOW and $\overline{WE}$ LOW. $\overline{CE}$ and $\overline{WE}$ must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data setup and hold timing must be referenced to the leading edge of the signal that terminates the write.

Timing Waveforms

Figure 3. Read Cycle No. 1 [10, 11]

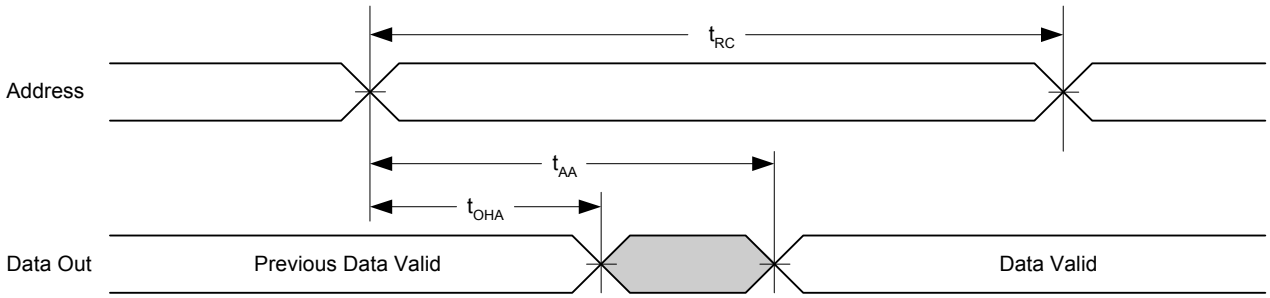
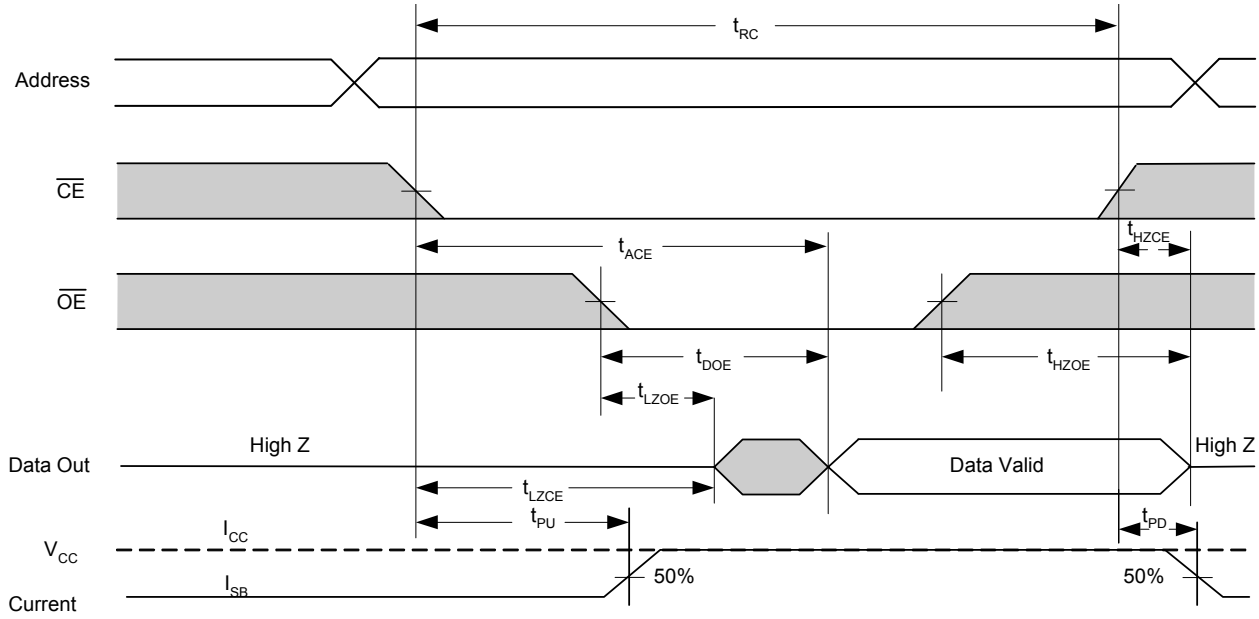


Figure 4. Read Cycle No. 2 [12, 13]



Notes

10. Device is continuously selected. $\overline{OE}$ = V_{IL} = $\overline{CE}$.
11. $\overline{WE}$ is HIGH for read cycle.
12. This cycle is $\overline{OE}$ controlled and $\overline{WE}$ is HIGH read cycle.
13. Address valid before or similar with $\overline{CE}$ transition LOW.

Timing Waveforms *(continued)*

Figure 5. Write Cycle No. 1 ($\overline{WE}$ Controlled) [14, 15, 16]

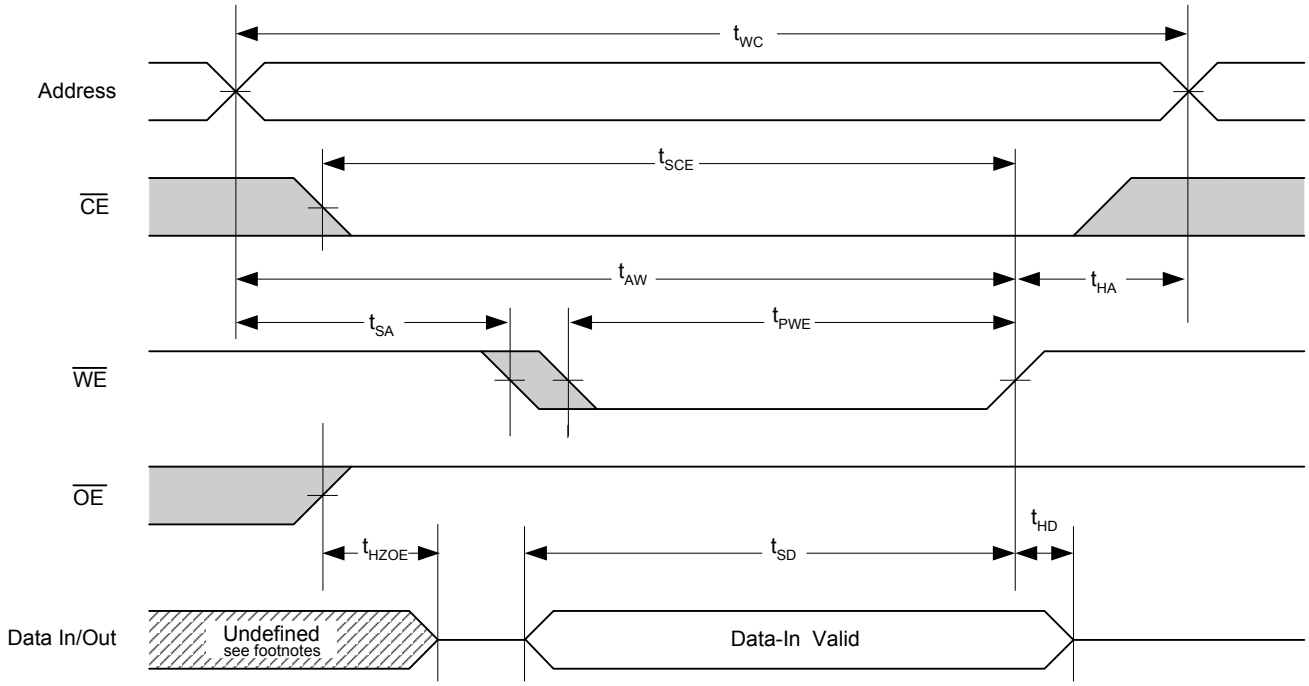
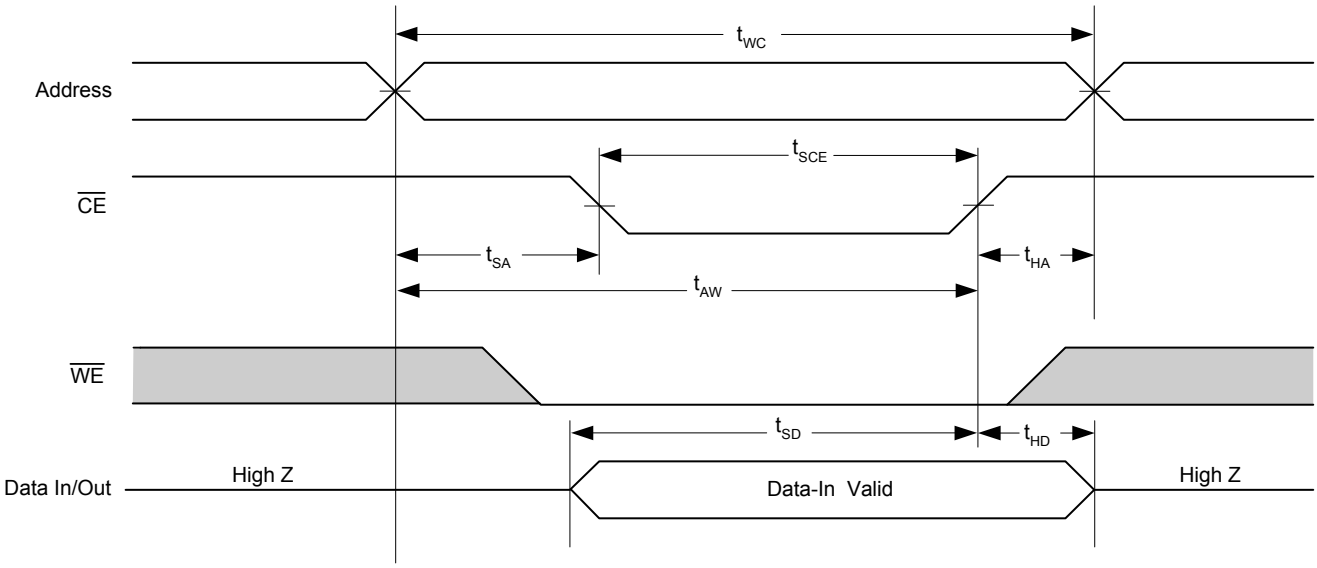


Figure 6. Write Cycle No. 2 ($\overline{CE}$ Controlled) [15, 17, 18]

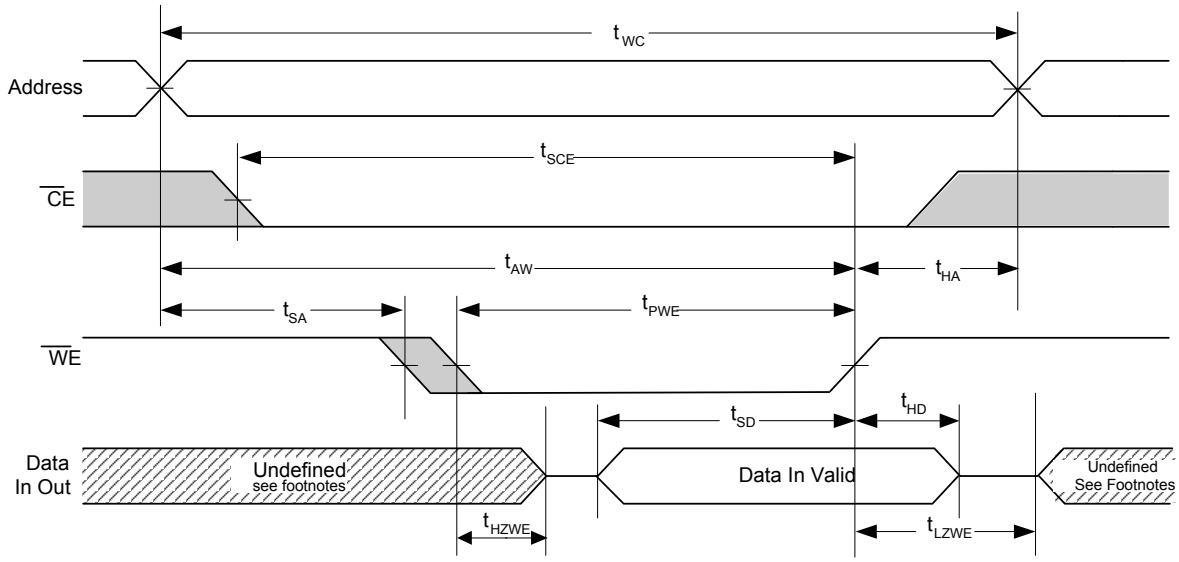


Notes

14. This cycle is $\overline{WE}$ controlled, $\overline{OE}$ is HIGH during write.
15. Data in and/or out is high impedance if $\overline{OE}$ = V_{IH}.
16. During this period the IOs are in output state and input signals must not be applied.
17. This cycle is $\overline{CE}$ controlled.
18. If $\overline{CE}$ goes HIGH simultaneously with $\overline{WE}$ going HIGH, the output remains in a high impedance state.

Timing Waveforms *(continued)*

Figure 7. Write Cycle No. 3 (WE Controlled, OE LOW) [19]



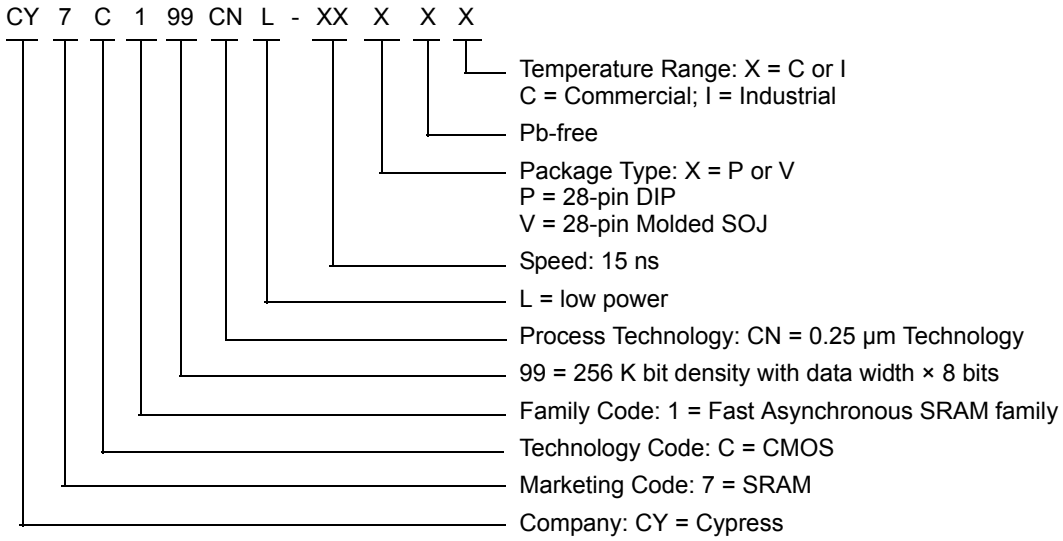
Note
19. The cycle is WE Controlled, OE LOW. The minimum write cycle time is the sum of t_{HZWE} and t_{SD}.

Ordering Information

Contact local sales representative regarding availability of these parts.

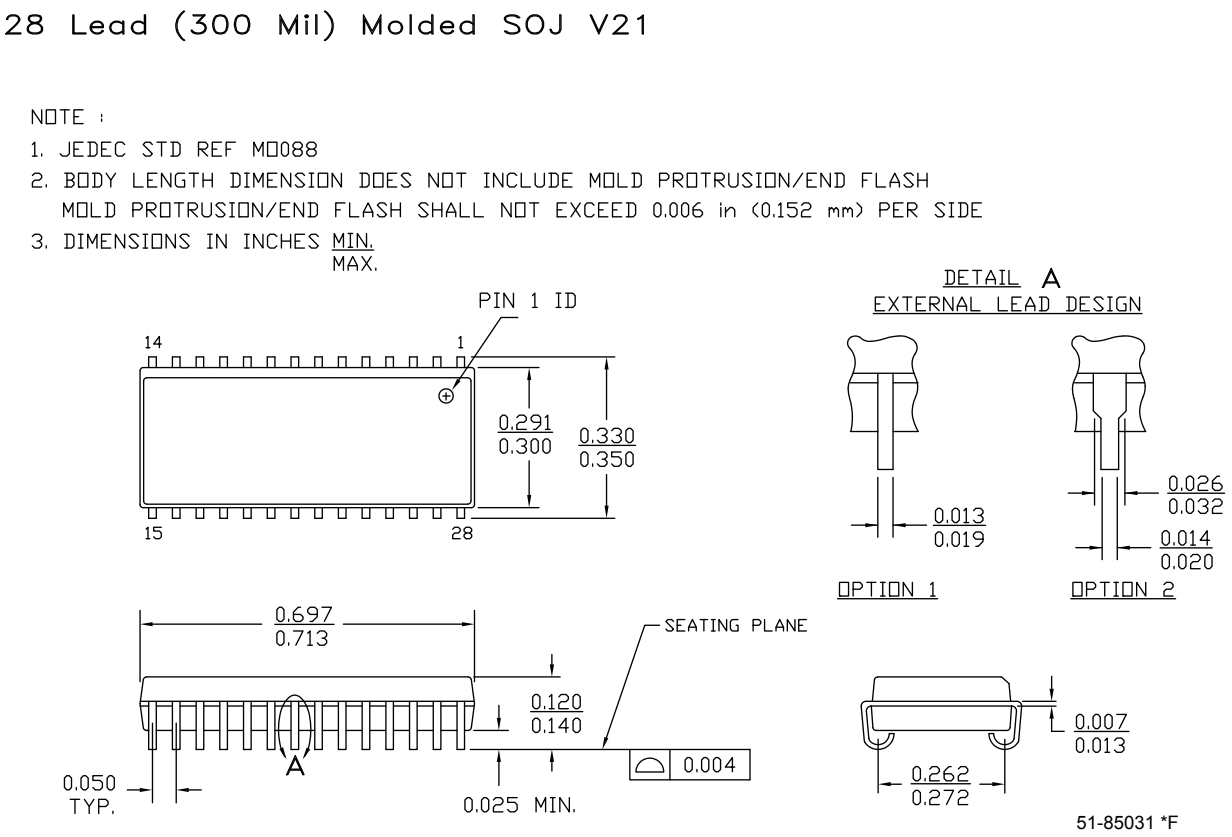
Speed (ns)	Ordering Code	Package Diagram	Package Type	Power Option	Operating Range
15	CY7C199CN-15PXC	51-85014	28-pin DIP (6.9 × 35.6 × 3.5 mm), Pb-free	Standard	Commercial
	CY7C199CNL-15VXI	51-85031	28-pin (300-Mil) Molded SOJ, Pb-free	Low Power	Industrial

Ordering Code Definitions



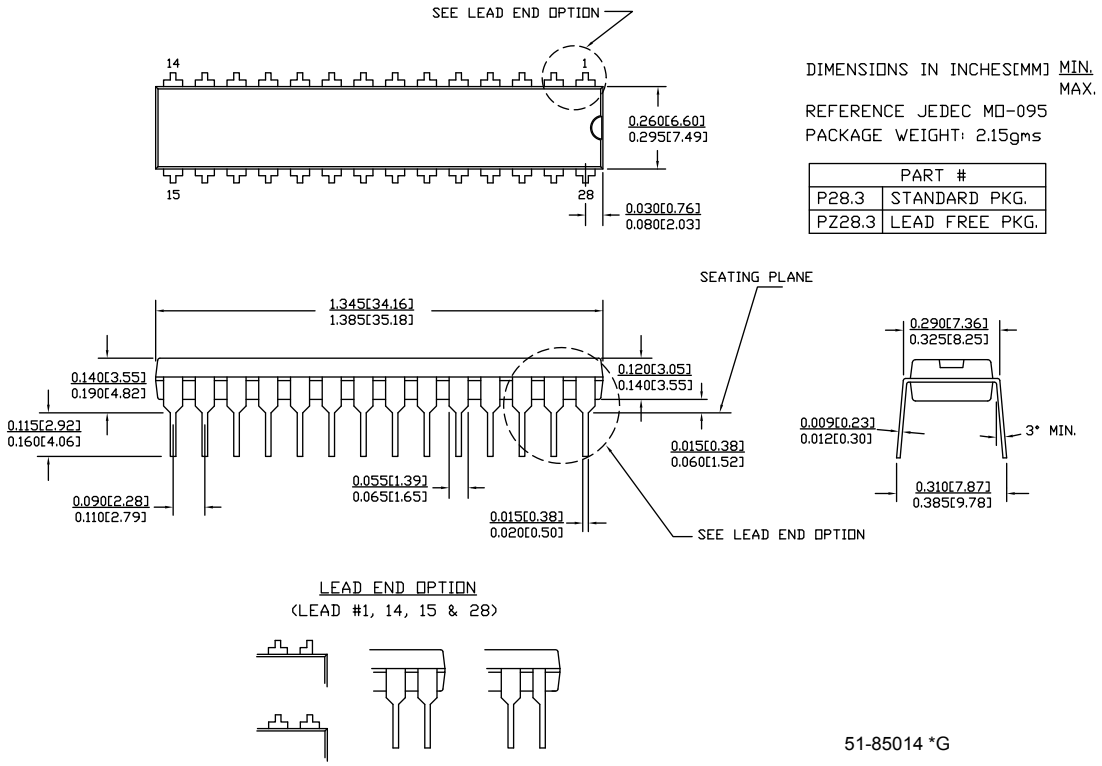
Package Diagrams

Figure 8. 28-pin SOJ (300 Mils) V28.3 Package Outline, 51-85031



Package Diagrams *(continued)*

Figure 9. 28-pin PDIP (300 Mils) Package Outline, 51-85014



Acronyms

Acronym	Description
$\overline{CE}$	Chip Enable
CMOS	Complementary Metal Oxide Semiconductor
I/O	Input/Output
$\overline{OE}$	Output Enable
SRAM	Static Random Access Memory
SOJ	Small Outline J-lead
VFBGA	Very Fine-Pitch Ball Grid Array
$\overline{WE}$	Write Enable

Document Conventions

Units of Measure

Symbol	Unit of Measure
°C	degree Celsius
MHz	megahertz
µA	microampere
mA	milliampere
mV	millivolt
mW	milliwatt
ns	nanosecond
pF	picofarad
V	volt
W	watt

Document History Page

Document Title: CY7C199CN, 256-Kbit (32 K × 8) Static RAM Document Number: 001-06435				
Revision	**ECN**	**Submission Date**	**Orig. of Change**	**Description of Change**
**	430363	See ECN	NXR	New data sheet.
*A	684342	See ECN	VKN	Added Automotive-A Information Updated Ordering Information Table
*B	839904	See ECN	VKN	Added t_{DOE} spec for Automotive-A part in AC Electrical characteristics table
*C	2896044	03/19/2010	NXR	Updated Ordering Information Table Updated Package Diagram
*D	3108898	12/13/2010	PRAS	Added Ordering Code Definitions.
*E	3198636	03/17/11	PRAS	Dislodged Automotive device information to 001-67737 Updated template and styles.
*F	3246329	05/04/2011	PRAS	Additional information on ISB1, ISB2 with respect to L parts
*G	3302830	08/02/2011	RAME	Removed all information related to 28-pin TSOP 1. Removed all information related to 20 ns speed bin. Removed the following parts from ordering information table. CY7C199CN-15VXC CY7C199CN-20ZXI Removed spec 51-85071.
*H	4318563	03/25/2014	VINI	Updated Package Diagrams: spec 51-85014 – Changed revision from *F to *G. Updated to new template. Completing Sunset Review.
*I	4546472	10/28/2014	VINI	Updated Maximum Ratings: Referred Note 2 in “Parameter” column. Updated AC Electrical Characteristics: Added Note 6 and referred the same note in “Parameter” column.
*J	4576406	01/16/2015	VINI	Added related documentation hyperlink in page 1. Updated Figure 8 in Package Diagrams (spec 51-85031 *E to *F).

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